

**FEATURES:**

- Typical  $t_{sk(o)}$  (Output Skew) < 250ps
- ESD > 2000V per MIL-STD-883, Method 3015; > 200V using machine model ( $C = 200\text{pF}$ ,  $R = 0$ )
- $V_{CC} = 3.3V \pm 0.3V$ , Normal Range
- $V_{CC} = 2.7V$  to  $3.6V$ , Extended Range
- CMOS power levels ( $0.4\mu\text{W}$  typ. static)
- All inputs, outputs, and I/O are 5V tolerant
- Available in SSOP and TSSOP packages

**DRIVE FEATURES:**

- Balanced Output Drivers:  $\pm 12\text{mA}$
- Low switching noise

**APPLICATIONS:**

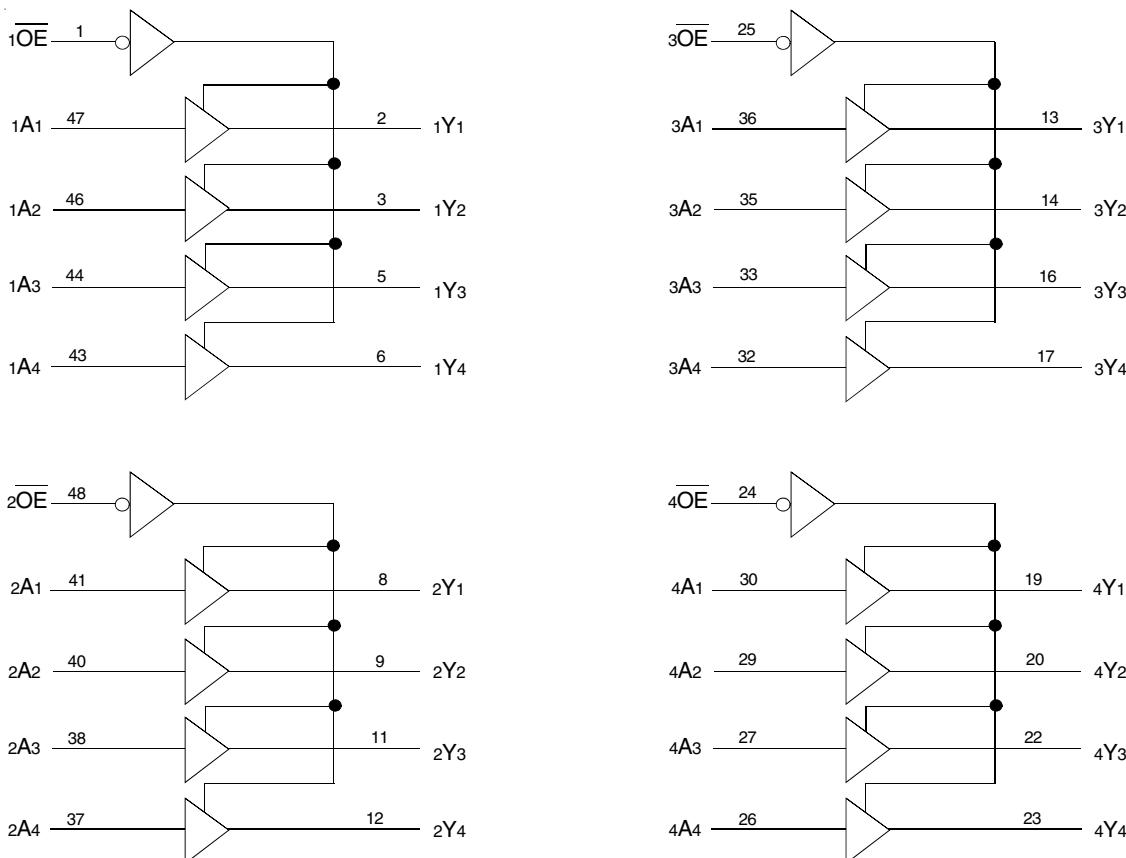
- 5V and 3.3V mixed voltage systems
- Data communication and telecommunication systems

**DESCRIPTION:**

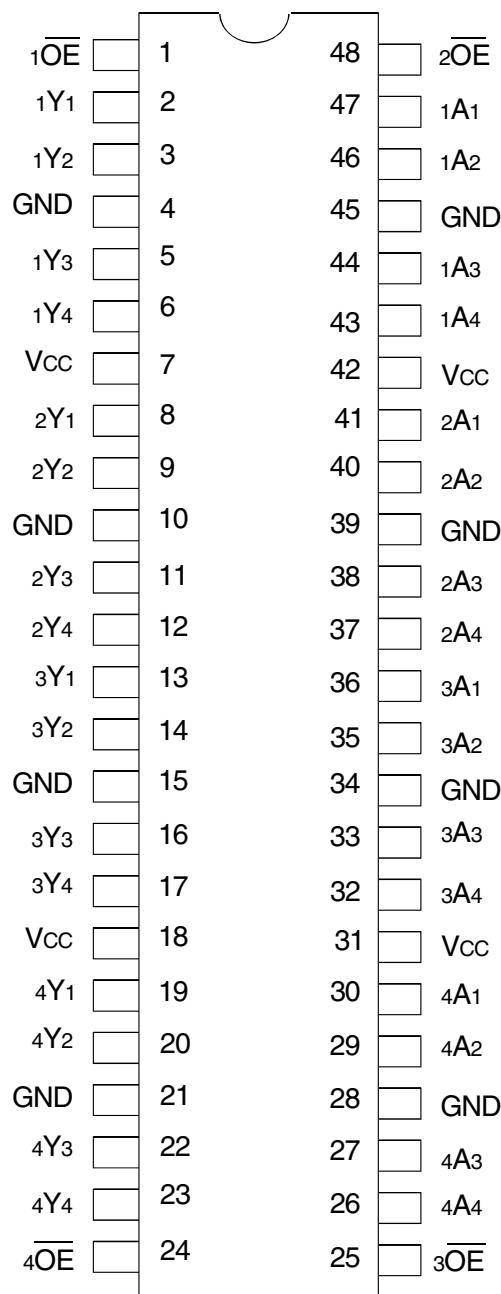
The LVC162244A 16-bit buffer/driver is built using advanced dual metal CMOS technology. The LVC162244A is designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. The device can be used as four 4-bit buffers, two 8-bit buffers, or one 16-bit buffer. This device provides true outputs and symmetrical active-low output-enable ( $\overline{OE}$ ) inputs.

All pins of this 16-bit buffer/driver can be driven from either 3.3V or 5V devices. This feature allows the use of the device as a translator in a mixed 3.3V/5V supply system.

The LVC162244A has series resistors in the device output structure which will significantly reduce line noise when used with light loads. This driver has been developed to drive  $\pm 12\text{mA}$  at the designated threshold levels.

**FUNCTIONAL BLOCK DIAGRAM**

## PIN CONFIGURATION



SSOP / TSSOP  
TOP VIEW

## ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

Symbol	Description	Max	Unit
VTERM <sup>(2)</sup>	Terminal Voltage with Respect to GND	-0.5 to +6.5	V
VTERM <sup>(3)</sup>	Terminal Voltage with Respect to GND	-0.5 to +6.5	V
TSTG	Storage Temperature	-65 to +150	°C
IOUT	DC Output Current	-50 to +50	mA
IIK	Continuous Clamp Current, VI < 0 or VO < 0	-50	mA
Icc	Continuous Current through each Vcc or GND	±100	mA
Iss			

NOTES:

1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
2. Vcc terminals.
3. All terminals except Vcc.

## CAPACITANCE (TA = +25°C, F = 1.0MHz)

Symbol	Parameter <sup>(1)</sup>	Conditions	Typ.	Max.	Unit
CIN	Input Capacitance	VIN = 0V	4.5	6	pF
COUT	Output Capacitance	VOUT = 0V	6.5	8	pF
C <sub>I/O</sub>	I/O Port Capacitance	VIN = 0V	6.5	8	pF

NOTE:

1. As applicable to the device type.

## PIN DESCRIPTION

Pin Names	Description
x $\bar{OE}$	3-State Output Enable Inputs (Active LOW)
xAx	Data Inputs
xYx	3-State Outputs

## FUNCTION TABLE (EACH 4-BIT BUFFER)<sup>(1)</sup>

Inputs		Outputs
x $\bar{OE}$	xAx	xYx
L	H	H
L	L	L
H	X	Z

NOTE:

1. H = HIGH Voltage Level  
X = Don't Care  
L = LOW Voltage Level  
Z = High-Impedance

## DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified:

Operating Condition:  $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$ 

Symbol	Parameter	Test Conditions		Min.	Typ. <sup>(1)</sup>	Max.	Unit
VIH	Input HIGH Voltage Level	Vcc = 2.3V to 2.7V		1.7	—	—	V
		Vcc = 2.7V to 3.6V		2	—	—	
VIL	Input LOW Voltage Level	Vcc = 2.3V to 2.7V		—	—	0.7	V
		Vcc = 2.7V to 3.6V		—	—	0.8	
IIH IIL	Input Leakage Current	Vcc = 3.6V	VI = 0 to 5.5V	—	—	$\pm 5$	$\mu\text{A}$
IOZH IOZL	High Impedance Output Current (3-State Output pins)	Vcc = 3.6V	VO = 0 to 5.5V	—	—	$\pm 10$	$\mu\text{A}$
IOFF	Input/Output Power Off Leakage	Vcc = 0V, VIN or VO $\leq$ 5.5V		—	—	$\pm 50$	$\mu\text{A}$
VIK	Clamp Diode Voltage	Vcc = 2.3V, IIN = $-18\text{mA}$		—	-0.7	-1.2	V
VH	Input Hysteresis	Vcc = 3.3V		—	100	—	mV
IcCL IcCH IcCZ	Quiescent Power Supply Current	Vcc = 3.6V		—	—	10	$\mu\text{A}$
		VIN = GND or Vcc $3.6 \leq VIN \leq 5.5\text{V}^{(2)}$		—	—	10	
$\Delta Icc$	Quiescent Power Supply Current Variation	One input at Vcc - 0.6V, other inputs at Vcc or GND		—	—	500	$\mu\text{A}$

## NOTES:

1. Typical values are at Vcc = 3.3V,  $+25^\circ\text{C}$  ambient.

2. This applies in the disabled state only.

## OUTPUT DRIVE CHARACTERISTICS

Symbol	Parameter	Test Conditions <sup>(1)</sup>		Min.	Max.	Unit
VOH	Output HIGH Voltage	Vcc = 2.3V to 3.6V	IOH = $-0.1\text{mA}$	Vcc - 0.2	—	V
		Vcc = 2.3V	IOH = $-4\text{mA}$	1.9	—	
			IOH = $-6\text{mA}$	1.7	—	
		Vcc = 2.7V	IOH = $-4\text{mA}$	2.2	—	
			IOH = $-8\text{mA}$	2	—	
		Vcc = 3V	IOH = $-6\text{mA}$	2.4	—	
			IOH = $-12\text{mA}$	2	—	
		Vcc = 2.3V to 3.6V	IOH = $0.1\text{mA}$	—	0.2	V
			IOH = $4\text{mA}$	—	0.4	
			IOH = $6\text{mA}$	—	0.55	
			IOH = $4\text{mA}$	—	0.4	
			IOH = $8\text{mA}$	—	0.6	
VOL	Output LOW Voltage	Vcc = 2.3V	IOH = $6\text{mA}$	—	0.55	V
			IOH = $12\text{mA}$	—	0.8	
		Vcc = 2.7V	IOH = $6\text{mA}$	—	0.55	
			IOH = $12\text{mA}$	—	0.8	
		Vcc = 3V	IOH = $6\text{mA}$	—	0.55	
			IOH = $12\text{mA}$	—	0.8	

## NOTE:

- VIH and VIL must be within the min. or max. range shown in the DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE table for the appropriate Vcc range.  $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$ .

OPERATING CHARACTERISTICS,  $T_A = 25^\circ\text{C}$

Symbol	Parameter	Test Conditions	Typical	Unit
CPD	Power Dissipation Capacitance per Buffer/Driver Outputs enabled	$CL = 0\text{pF}, f = 10\text{MHz}$	35	$\text{pF}$
CPD	Power Dissipation Capacitance per Buffer/Driver Outputs disabled		4	

SWITCHING CHARACTERISTICS<sup>(1)</sup>

Symbol	Parameter	$V_{CC} = 2.7\text{V}$		$V_{CC} = 3.3\text{V} \pm 0.3\text{V}$		Unit
		Min.	Max.	Min.	Max.	
$t_{PLH}$	Propagation Delay $x_{Ax}$ to $x_{Yx}$	—	5.6	1.1	4.4	ns
$t_{PHL}$						
$t_{PZH}$	Output Enable Time $x_{\overline{OE}}$ to $x_{Yx}$	—	6.9	1	5.5	ns
$t_{PZL}$						
$t_{PHZ}$	Output Disable Time $x_{\overline{OE}}$ to $x_{Yx}$	—	6.8	1.8	6.3	ns
$t_{PLZ}$						
$t_{SK(o)}$	Output Skew <sup>(2)</sup>	—	—	—	500	ps

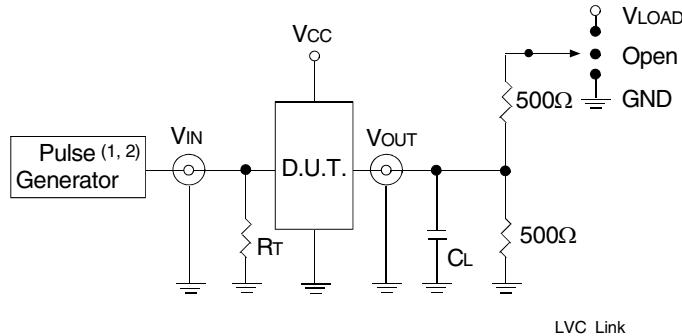
NOTES:

1. See TEST CIRCUITS AND WAVEFORMS.  $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$ .
2. Skew between any two outputs of the same package and switching in the same direction.

## TEST CIRCUITS AND WAVEFORMS

### TEST CONDITIONS

Symbol	$V_{CC}^{(1)} = 3.3V \pm 0.3V$	$V_{CC}^{(1)} = 2.7V$	$V_{CC}^{(2)} = 2.5V \pm 0.2V$	Unit
$V_{LOAD}$	6	6	$2 \times V_{CC}$	V
$V_{IH}$	2.7	2.7	$V_{CC}$	V
$V_T$	1.5	1.5	$V_{CC} / 2$	V
$V_{LZ}$	300	300	150	mV
$V_{HZ}$	300	300	150	mV
$C_L$	50	50	30	pF



Test Circuit for All Outputs

### DEFINITIONS:

$C_L$  = Load capacitance: includes jig and probe capacitance.

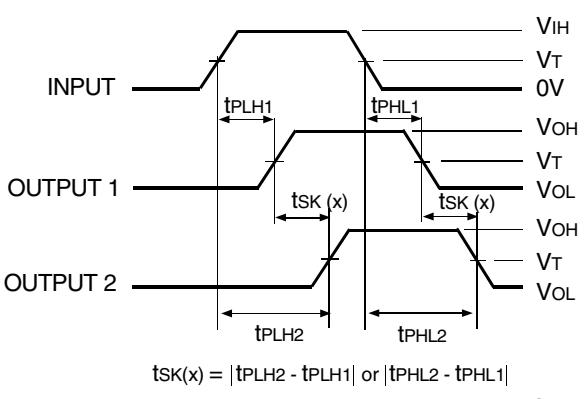
$R_t$  = Termination resistance: should be equal to  $Z_{OUT}$  of the Pulse Generator.

### NOTES:

1. Pulse Generator for All Pulses: Rate  $\leq 10MHz$ ;  $t_f \leq 2.5ns$ ;  $t_r \leq 2.5ns$ .
2. Pulse Generator for All Pulses: Rate  $\leq 10MHz$ ;  $t_f \leq 2ns$ ;  $t_r \leq 2ns$ .

### SWITCH POSITION

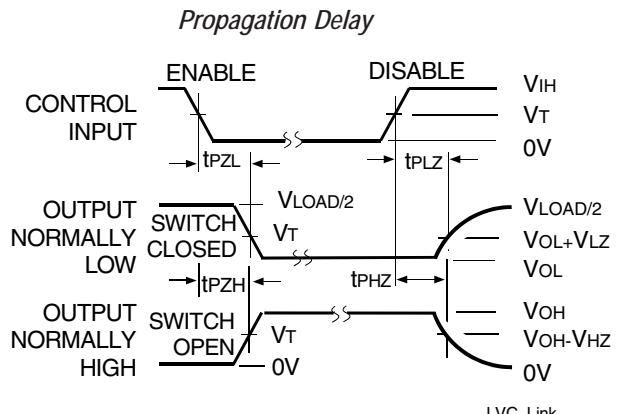
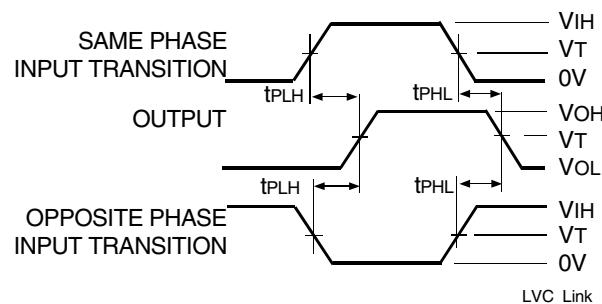
Test	Switch
Open Drain	
Disable Low	$V_{LOAD}$
Enable Low	
Disable High	$GND$
Enable High	
All Other Tests	Open



Output Skew -  $tsk(x)$

### NOTES:

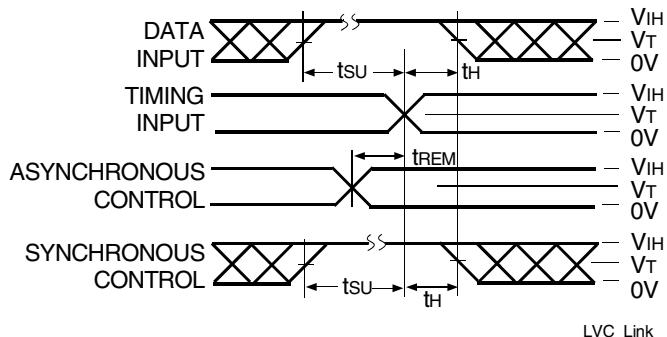
1. For  $tsk(o)$  OUTPUT1 and OUTPUT2 are any two outputs.
2. For  $tsk(b)$  OUTPUT1 and OUTPUT2 are in the same bank.



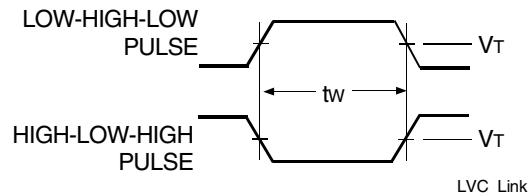
Enable and Disable Times

### NOTE:

1. Diagram shown for input Control Enable-LOW and input Control Disable-HIGH.

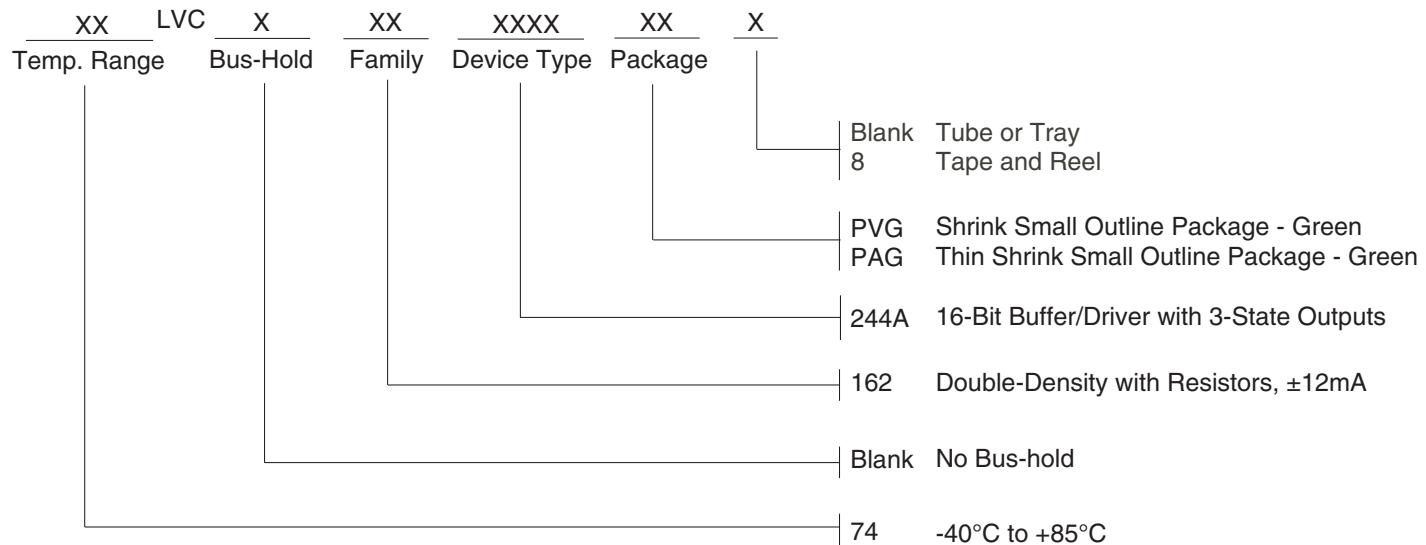


Set-up, Hold, and Release Times



Pulse Width

## ORDERING INFORMATION



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